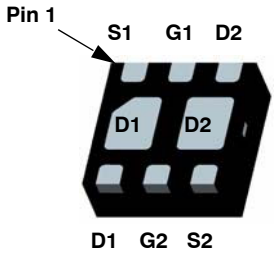
MOSFET – Dual, P-Channel, POWERTRENCH®

30 V, -29 A, 90 mΩ

FDMA3023PZ



MicroFET
WDFN6 2X2, 0.65P
CASE 511DA

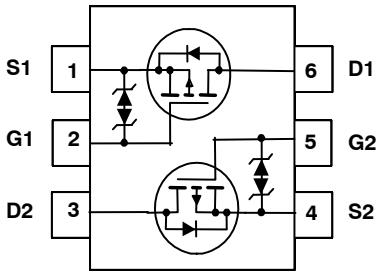
Description

This Device is Designed Specifically as a Single Package Solution for the battery charge switch in cellular handset and other Ultra−Portable Applications. It features two independent P−Channel MOSFETs with low on−state resistance for minimum conduction losses. When connected in the typical common source configuration, bi−directional current flow is possible.

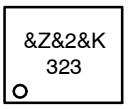
The MicroFET 2X2 Package Offers Exceptional Thermal Performance for its physical size and is well suited to linear mode applications.

Features

- Max $R_{DS(on)}$ = 90 mΩ at V_{GS} = −4.5 V, I_D = −2.9 A
- Max $R_{DS(on)}$ = 130 mΩ at V_{GS} = −2.5 V, I_D = −2.6 A
- Max $R_{DS(on)}$ = 170 mΩ at V_{GS} = −1.8 V, I_D = −1.7 A
- Max $R_{DS(on)}$ = 240 mΩ at V_{GS} = −1.5 V, I_D = −1.0 A
- Low Profile − 0.8 mm Maximum − in the New Package MicroFET™ 2x2 mm
- HBM ESD Protection > 2 kV (Note 3)
- These Devices is Pb−Free, Halide Free and is RoHS Compliant
- Free From Halogenated Compounds and Antimony Oxides



MARKING DIAGRAM



&Z = Assembly Plant Code
&2 = 2−Digit Date−Code
&K = 2−Digit Lot Code
323 = Specific Device Code

ABSOLUTE MAXIMUM RATINGS T_A = 25°C unless otherwise noted

Symbol	Parameter	Value	Unit
V_{DS}	Drain to Source Voltage	−30	V
V_{GS}	Gate to Source Voltage	±8	V
I_D	Drain Current − Continuous (Note 1a) − Pulsed	 −2.9 −6	A
P_D	Power Dissipation T_A = 25°C (Note 1a)	1.4	W
	Power Dissipation T_A = 25°C (Note 1b)	0.7	
T_J, T_{stg}	Operating and Storage Junction Temperature Range	−55 to +150	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

ORDERING INFORMATION

Device	Package	Shipping†
FDMA3023PZ	WDFN−6 (Pb−Free)	3000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

© Semiconductor Components Industries, LLC, 2016

THERMAL CHARACTERISTICS

Symbol	Parameter	Value	Unit
$R_{\theta JA}$	Thermal Resistance for Single Operation, Junction to Ambient (Note 1a)	86	°C/W
$R_{\theta JA}$	Thermal Resistance for Single Operation, Junction to Ambient (Note 1b)	173	°C/W
$R_{\theta JA}$	Thermal Resistance for Dual Operation, Junction to Ambient (Note 1c)	69	°C/W
$R_{\theta JA}$	Thermal Resistance for Dual Operation, Junction to Ambient (Note 1d)	151	°C/W

ELECTRICAL CHARACTERISTICS T_J = 25°C unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
Off Characteristics						
BV_{DSS}	Drain to Source Breakdown Voltage	I_D = −250 μA, V_{GS} = 0 V	−30	–	–	V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	I_D = −250 μA, Referenced to 25°C	–	−24	–	mV/°C
I_{DSS}	Zero Gate Voltage Drain Current	V_{DS} = −24 V, V_{GS} = 0 V	–	–	−1	μA
I_{GSS}	Gate to Source Leakage Current	V_{GS} = ±8 V, V_{DS} = 0 V	–	–	±100	nA
On Characteristics						
$V_{GS(th)}$	Gate to Source Threshold Voltage	V_{GS} = V_{DS}, I_D = −250 μA	−0.4	−0.6	−1.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I_D = −250 μA, Referenced to 25°C	–	3	–	mV/°C
$R_{DS(on)}$	Static Drain−Source On−Resistance	V_{GS} = −4.5 V, I_D = −2.9 A V_{GS} = −2.5 V, I_D = −2.6 A, V_{GS} = −1.8 V, I_D = −1.7 A, V_{GS} = −1.5 V, I_D = −1.0 A, V_{GS} = −4.5 V, I_D = −2.9 A, T_J = 125°C	– – – – –	71 97 122 151 110	90 130 170 240 140	mΩ
g_{FS}	Forward Transconductance	V_{DS} = −5 V, I_D = −2.9 A	–	10	–	S
Dynamic Characteristics						
C_{iss}	Input Capacitance	V_{DS} = −15 V, V_{GS} = 0 V, f = 1 MHz	–	400	530	pF
C_{oss}	Output Capacitance		–	55	70	pF
C_{rss}	Reverse Transfer Capacitance		–	45	65	pF
Switching Characteristics						
$t_{d(on)}$	Turn−On Delay Time	V_{DD} = −15 V, I_D = −1.0 A, V_{GS} = −4.5 V, R_{GEN} = 6 Ω	–	5	10	ns
t_r	Rise Time		–	4	10	ns
$t_{d(off)}$	Turn−Off Delay Time		–	62	100	ns
t_f	Fall Time		–	18	33	ns
Q_{gTOT}	Total Gate Charge	V_{DD} = −15 V, I_D = −2.9 A, V_{GS} = −4.5 V	– –	7.9 0.9	11 –	nC nC
Q_{gs}	Gate to Source Gate Charge		–	1.9	–	nC
Q_{gd}	Gate to Drain “Miller” Charge					
Drain−Source Diode Characteristics and Maximum Ratings						
I_S	Maximum Continuous Drain−Source Diode Forward Current		–	–	−1.1	A
V_{SD}	Source to Drain Diode Forward Voltage	V_{GS} = 0 V, I_S = −1.1 A (Note 2)	–	−0.8	−1.2	V
t_{rr}	Reverse Recovery Time	I_F = −2.9 A, di/dt = 100 A/μs	–	18	33	ns
Q_{rr}	Reverse Recovery Charge		–	6.6	13	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

NOTES:

1. $R_{\theta JA}$ is determined with the device mounted on a 1 in^2 oz. copper pad on a 1.5 x 1.5 in. board of FR−4 material. $R_{\theta JC}$ is guaranteed by design while $R_{\theta JA}$ is determined by the user's board design.

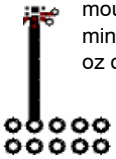
   (a) $R_{\theta JA}$ = 86 °C/W when mounted on a 1 in^2 pad of 2 oz copper, 1.5 " x 1.5 " x 0.062 " thick PCB. For single operation.

   (b) $R_{\theta JA}$ = 173 °C/W when mounted on a minimum pad of 2 oz copper. For single operation.

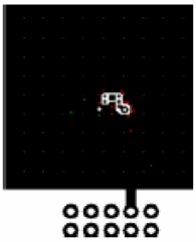
   (c) $R_{\theta JA}$ = 69 °C/W when mounted on a 1 in^2 pad of 2 oz copper, 1.5 " x 1.5 " x 0.062 " thick PCB. For dual operation.

   (d) $R_{\theta JA}$ = 151 °C/W when mounted on a minimum pad of 2 oz copper. For dual operation.

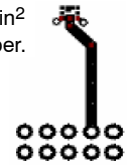
a).86 °C/W when mounted on a 1 in^2 pad of 2 oz copper.



b).173 °C/W when mounted on a minimum pad of 2 oz copper.



c).69 °C/W when mounted on a 1 in^2 pad of 2 oz copper.



d).151 °C/W when mounted on a minimum pad of 2 oz copper.

2. Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2.0%
3. The diode connected between the gate and source serves only as protection against ESD. No gate overvoltage rating is implied.

TYPICAL CHARACTERISTICS Tc = 25 °C unless otherwise noted

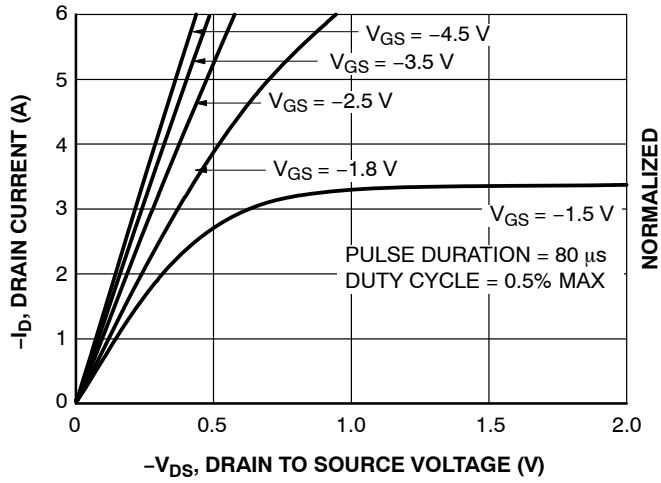


Figure 1. On−Region Characteristics

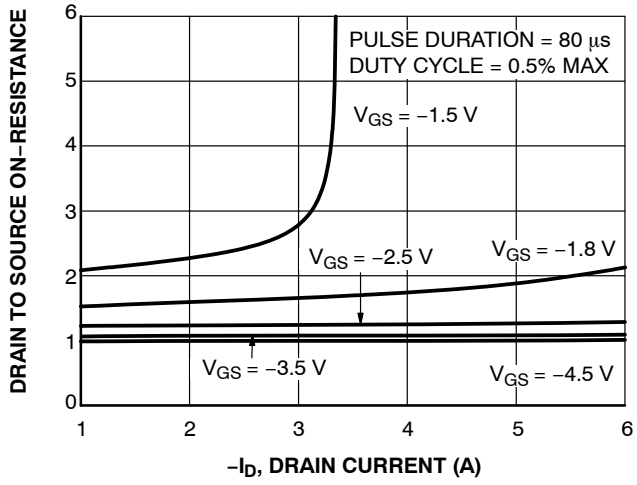


Figure 2. Normalized On−Resistance vs. Drain Current and Gate Voltage

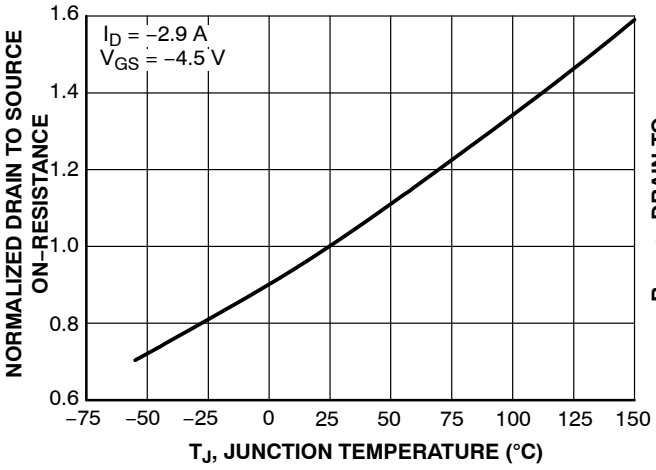


Figure 3. Normalized On−Resistance vs Junction Temperature

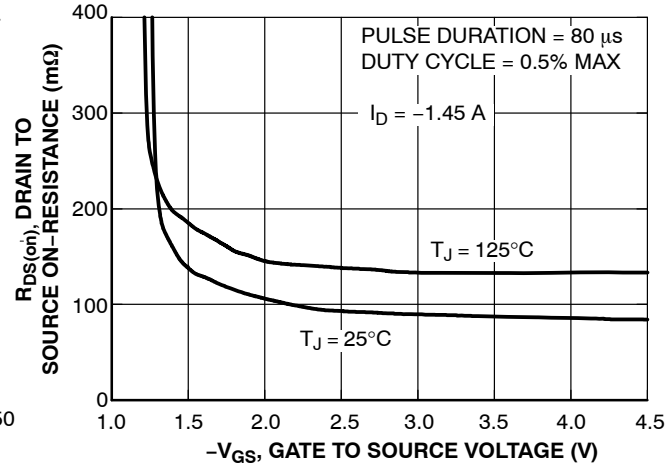


Figure 4. On−Resistance vs Gate to Source Voltage

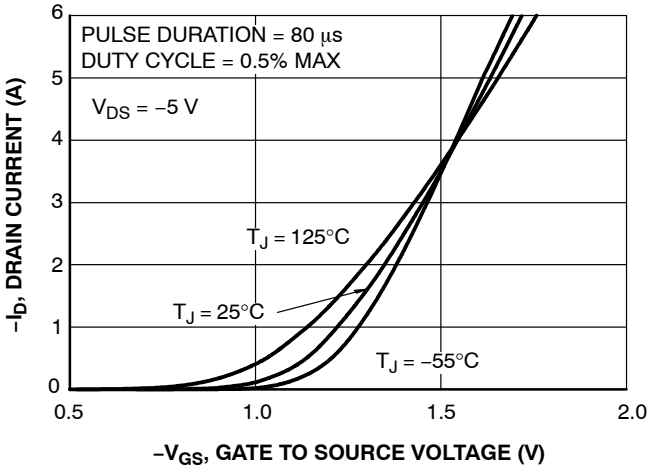


Figure 5. Transfer Characteristics

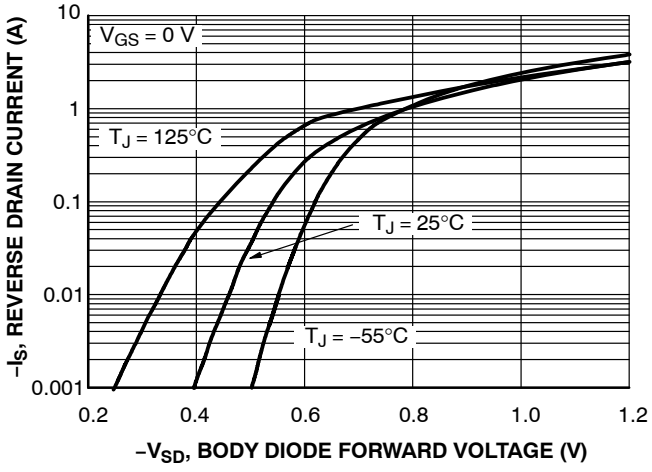


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

TYPICAL CHARACTERISTICS Tc = 25 °C unless otherwise noted (CONTINUED)

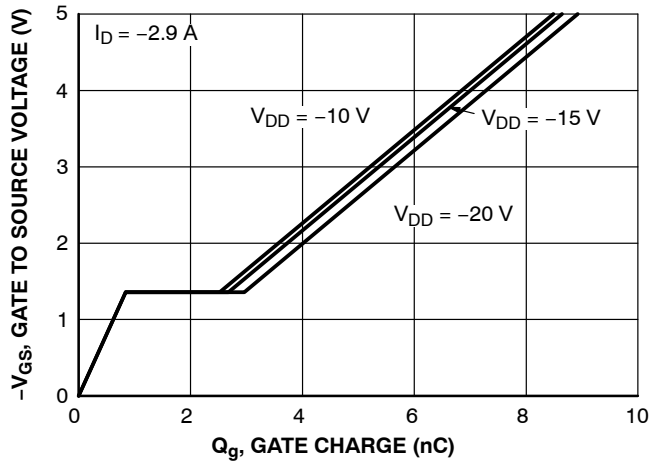


Figure 7. Gate Charge Characteristics

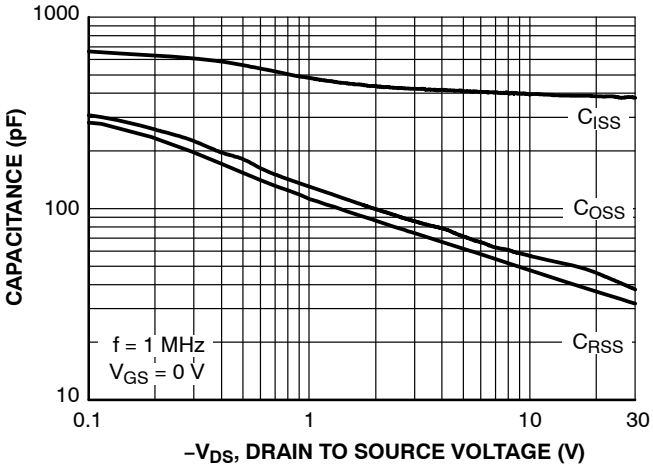


Figure 8. Capacitance vs Drain to Source Voltage

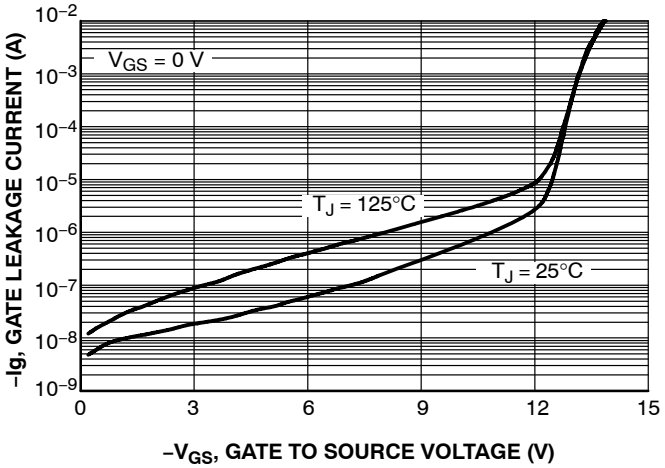


Figure 9. Gate Leakage vs Gate to Source Voltage

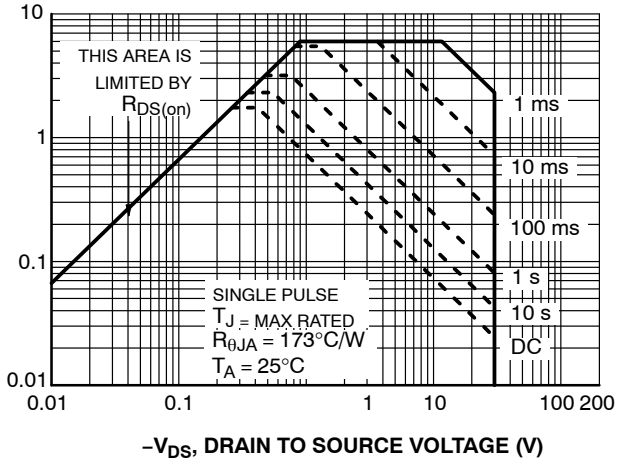


Figure 10. Forward Bias Safe Operating Area

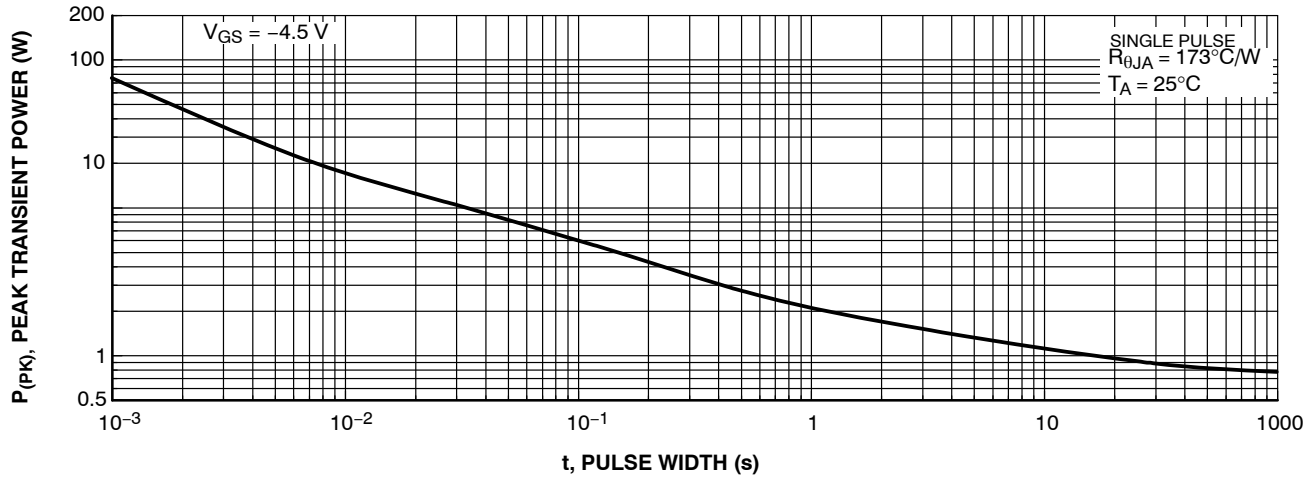


Figure 11. Single Pulse Maximum Power Dissipation

TYPICAL CHARACTERISTICS Tc = 25 °C unless otherwise noted (CONTINUED)

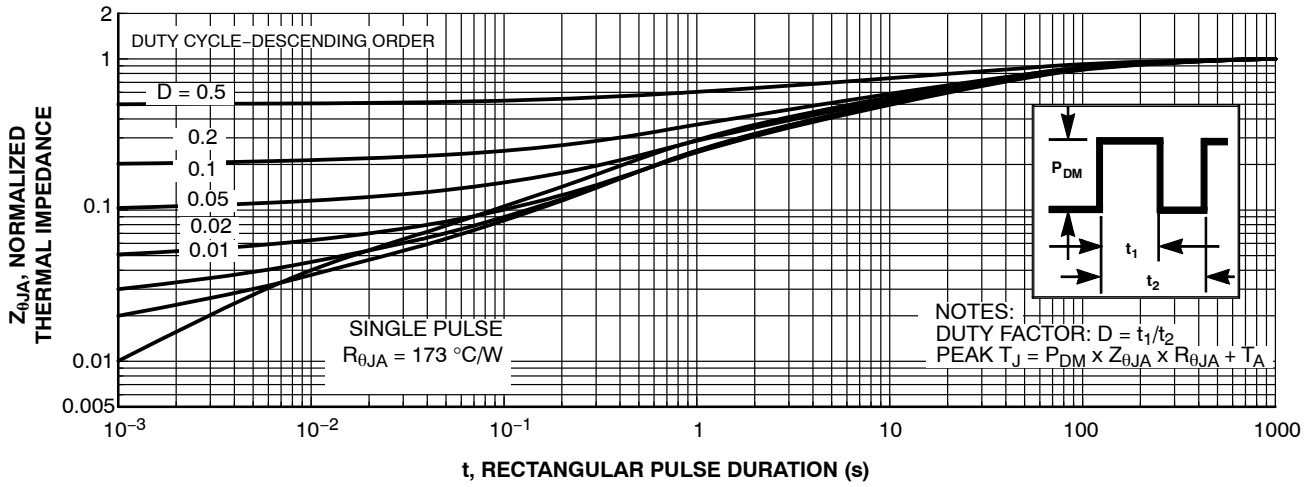
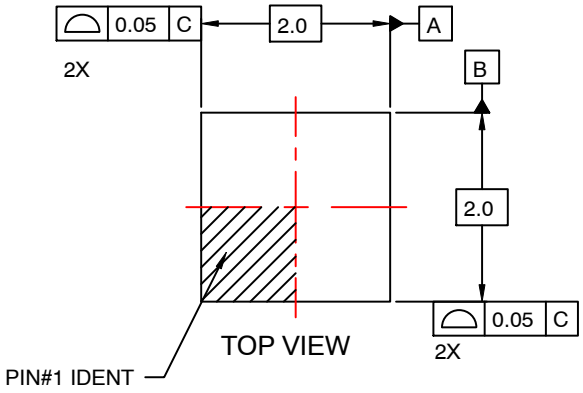


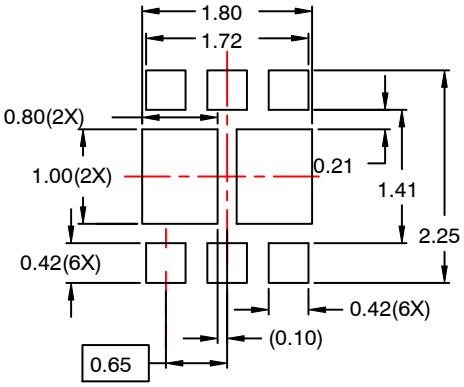
Figure 12. Junction−to−Ambient Transient Thermal Response Curve

POWERTRENCH is registered trademark and MicroFET is a trademark of Semiconductor Components Industries, LLC dba “**onsemi**” or its affiliates and/or subsidiaries in the United States and/or other countries.

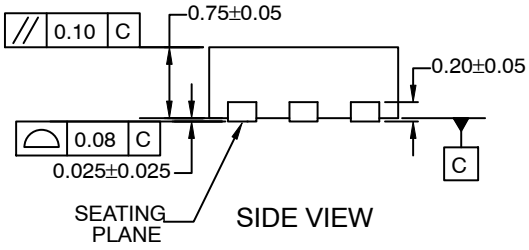
WDFN6 2x2, 0.65P
CASE 511DA
ISSUE O

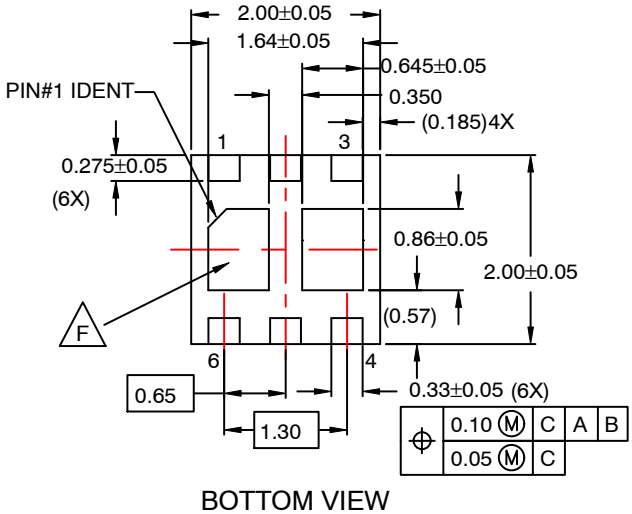
DATE 31 JUL 2016





RECOMMENDED
LAND PATTERN





NOTES:

A. CONFORM TO JADEC REGISTRATIONS MO−229, VARIATION VCCC, EXCEPT WHERE NOTED.

B. DIMENSIONS ARE IN MILLIMETERS.

C. DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 2009.

D. LAND PATTERN RECOMMENDATION IS EXISTING INDUSTRY LAND PATTERN.

F. NON−JEDEC DUAL DAP

DOCUMENT NUMBER:	**98AON13615G**	Electronic versions are uncontrolled except when accessed directly from the Document Repository. Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.	
DESCRIPTION:	**WDFN6 2X2, 0.65P**		**PAGE 1 OF 1**

onsemi and onsemi are trademarks of Semiconductor Components Industries, LLC dba **onsemi** or its subsidiaries in the United States and/or other countries. **onsemi** reserves the right to make changes without further notice to any products herein. **onsemi** makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does **onsemi** assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. **onsemi** does not convey any license under its patent rights nor the rights of others.

onsemi, ONSEMI , and other names, marks, and brands are registered and/or common law trademarks of Semiconductor Components Industries, LLC dba "**onsemi**" or its affiliates and/or subsidiaries in the United States and/or other countries. **onsemi** owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of **onsemi**'s product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent−Marking.pdf. **onsemi** reserves the right to make changes at any time to any products or information herein, without notice. The information herein is provided "as−is" and **onsemi** makes no warranty, representation or guarantee regarding the accuracy of the information, product features, availability, functionality, or suitability of its products for any particular purpose, nor does **onsemi** assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using **onsemi** products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by **onsemi**. "Typical" parameters which may be provided in **onsemi** data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. **onsemi** does not convey any license under any of its intellectual property rights nor the rights of others. **onsemi** products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use **onsemi** products for any such unintended or unauthorized application, Buyer shall indemnify and hold **onsemi** and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that **onsemi** was negligent regarding the design or manufacture of the part. **onsemi** is an Equal Opportunity/Affirmative Action Employer. This literature is subject to all applicable copyright laws and is not for resale in any manner.

ADDITIONAL INFORMATION

TECHNICAL PUBLICATIONS:
Technical Library: www.onsemi.com/design/resources/technical−documentation
onsemi Website: www.onsemi.com

ONLINE SUPPORT: www.onsemi.com/support
For additional information, please contact your local Sales Representative at
www.onsemi.com/support/sales